# **MOSFET** – Power, Single, N-Channel, $\mu$ 8FL 60 V, 24 m $\Omega$

#### Features

- Small Footprint (3.3 x 3.3 mm) for Compact Designs
- Low Q<sub>G(TOT)</sub> to Minimize Switching Losses
- Low Capacitance to Minimize Driver Losses
- These are Pb-Free Devices

#### Applications

- Motor Drivers
- DC-DC Converters
- Synchronous Rectification
- Power Management

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	е		V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	V <sub>GS</sub>	±20	V		
Continuous Drain		T <sub>mb</sub> = 25°C	۱ <sub>D</sub>	20	А
Current $R_{\Psi J-mb}$ (Notes 1, 2, and 3)		$T_{mb} = 100^{\circ}C$		14	
Power Dissipation		T <sub>mb</sub> = 25°C	PD	19	W
$R_{\Psi J-mb}$ (Notes 1, 2, and 3)	Steady	$T_{mb} = 100^{\circ}C$		10	
Continuous Drain	State	$T_A = 25^{\circ}C$	۱ <sub>D</sub>	8	А
Current R <sub>θJA</sub> (Notes 1 & 3)		T <sub>A</sub> = 100°C		6	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.1	W
R <sub>θJA</sub> (Notes 1 & 3)		$T_A = 100^{\circ}C$		1.6	
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		I <sub>DM</sub>	133	А
Operating Junction and	T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C		
Source Current (Body D	I <sub>S</sub>	20	А		
Single Pulse Drain-to-S Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> $I_{L(pk)}$ = 14.4 A, L = 1.0 m	E <sub>AS</sub>	20	mJ		
Lead Temperature for S (1/8" from case for 10 s)		Purposes	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	7.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\thetaJA}$	48	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

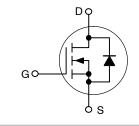


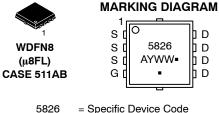
# **ON Semiconductor®**

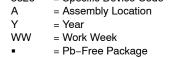
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
60 V	24 mΩ @ 10 V	20 A
	32 mΩ @ 4.5 V	20 A









(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTFS5826NLTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS5826NLTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

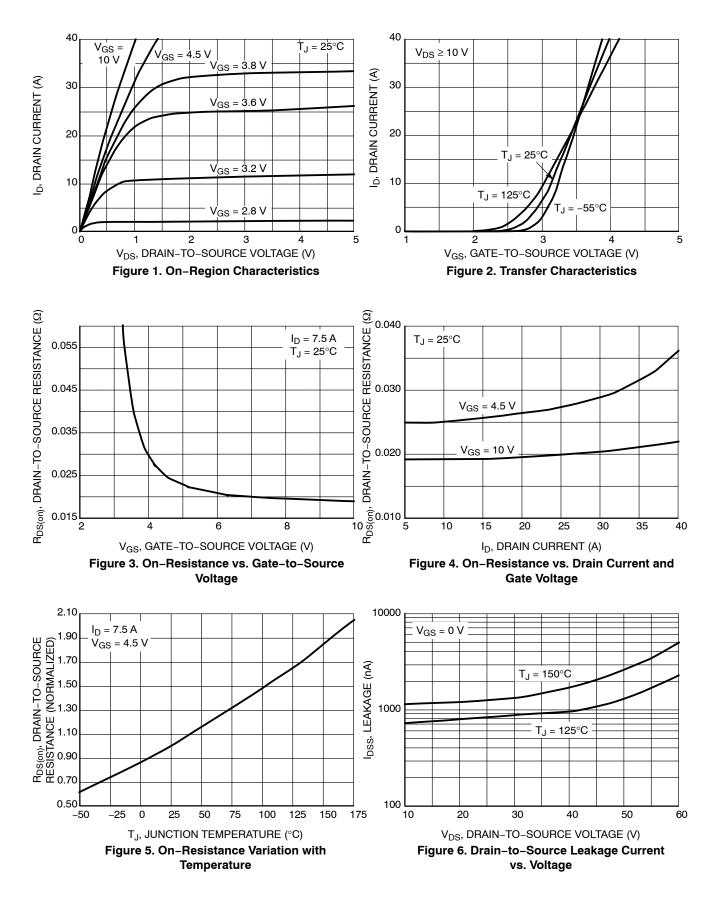
- Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
  Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

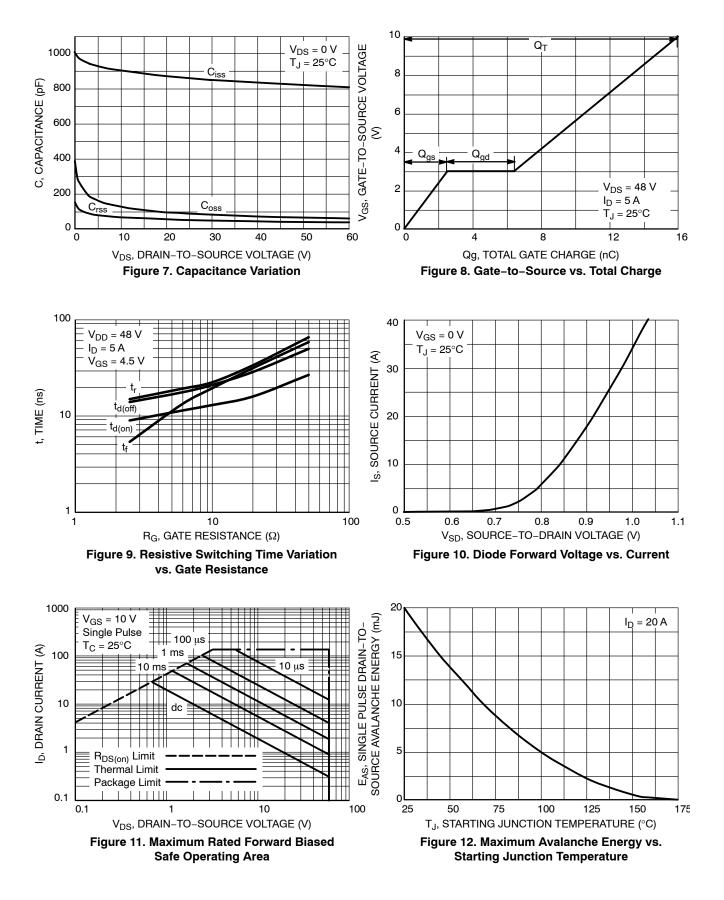
Parameter	Symbol	Test Cond	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	-	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	250 μΑ	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				58.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 60 V$	$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.5		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 7.5 A		19	24	mΩ
		$V_{GS}$ = 4.5 V	I <sub>D</sub> = 7.5 A		25	32	
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 15 V, I <sub>D</sub>	= 5.0 A		8		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE					
Input Capacitance	C <sub>iss</sub>				850		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MH	lz, V <sub>DS</sub> = 25 V		85		
Reverse Transfer Capacitance	C <sub>rss</sub>			50			
Total Gate Charge	Q <sub>G(TOT)</sub>			8.4		nC	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>D</sub>	s = 48 V.		1.0		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 5.0		2.5			
Gate-to-Drain Charge	Q <sub>GD</sub>				3.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48V, I <sub>D</sub> = 5.0A			16	25	nC
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			1.5		Ω
SWITCHING CHARACTERISTICS (No	ote 5)				•	•	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 48 V,			9.0	18	ns
Rise Time	t <sub>r</sub>				15	28	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = 5.0 \rm{A}, \rm{R}_{\rm G}$	$= 2.5 \Omega$		14	25	-
Fall Time	t <sub>f</sub>				5.4	12	1
Turn-On Delay Time	t <sub>d(on)</sub>				7.0	12	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	s = 48 V.		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{\rm D} = 5.0 \rm{A},  R_{\rm G}$			17	30	1
Fall Time	t <sub>f</sub>				3.5	6.0	
DRAIN-SOURCE DIODE CHARACTE	RISTICS						1
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	2.3	V
		$I_{\rm S} = 7.5 \rm{A}$	T <sub>J</sub> = 125°C		0.7	1	1
Reverse Recovery Time	t <sub>RR</sub>				15		ns
Charge Time	t <sub>a</sub>	$V_{GS} = 0 V, d_{IS}/d_t$	- 100 A/us		12		1
Discharge Time	t <sub>b</sub>	$v_{GS} = 0 v, u_{S}/u_{t} = 1.0$			4		-
Reverse Recovery Charge	Q <sub>RR</sub>				13		nC

 $\begin{array}{ll} \mbox{4. Pulse Test: pulse width = 300 $\mu$s, duty cycle $\le 2\%$.} \\ \mbox{5. Switching characteristics are independent of operating junction temperatures.} \end{array}$ 

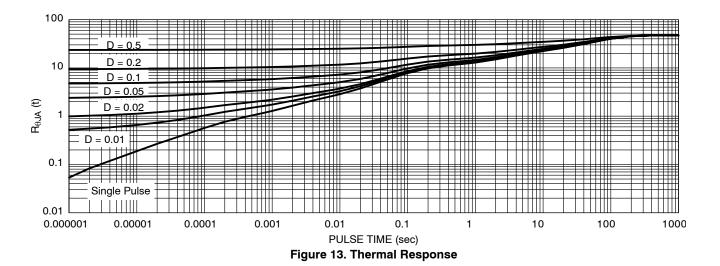
#### **TYPICAL CHARACTERISTICS**



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Pb-Free indicator, "G" or microdot " .", may or may not be present.

DATE 23 APR 2012

NOTES:

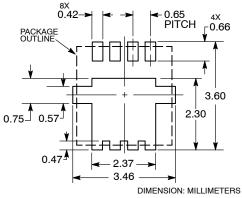
DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH 1. 2.

З. RS.

PROTRUSIONS OR GATE BUR

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
с	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC	)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC		0	.130 BSC	)		
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			0.026 BSC		2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
м	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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